

Multi-Channel

Silicon ESD Protector Overvoltage Protection Device

PRODUCT: SESD0802Q4UG-0020-090

DOCUMENT: SCD28189 REV LETTER: A REV DATE: December 6, 2011 PAGE NO.: Page 1 of 6

Specification Status: Preliminary

BENEFITS

- Industry-leading lowest capacitance; provides lowest insertion loss for high speed data signals
- Industry's smallest footprint and lowest profile multi-channel ESD array helps to optimize board space
- Flow-through and single connection design helps routing PCB matched impedance high speed data lines
- Helps protect electronic circuits against damage from Electrostatic Discharge (ESD), surge and cable discharge events
- Assists equipment to pass IEC61000-4-2, level 4 testing

FEATURES

- Low capacitance: 0.20 pF (typ)
- Low leakage current: 50nA @ 5V (max)
 Low clamping voltage: +9.18 / -0.8V (typ)
- Low clamping voltage: +9.187-0.87 (typ @ (tp=8x20µs, Ipp=2A)
- ESD maximum rating per IEC61000-4-2 standard:
 - ± 20kV contact discharge
 - ± 20kV air discharge
- Surge: 2A (max) @ (tp=8x20µs) per IEC61000-4-2-5
- Small size and low profile: XDFN array packages 0.31mm height

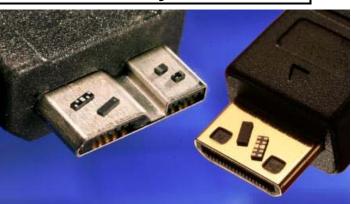
APPLICATIONS

- Consumer, mobile and portable electronics
- Tablet PC and external storage with high speed interfaces
- Ultra-high speed data lines
- USB 3.0/2.0, HDMI 1.3/1.4, DisplayPort, Thunderbolt (Light Peak), V-by-One HS, and LVDS interfaces
- Applications requiring high ESD performance in small DFN packages

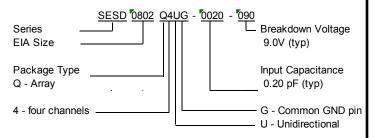
MATERIALS INFORMATION



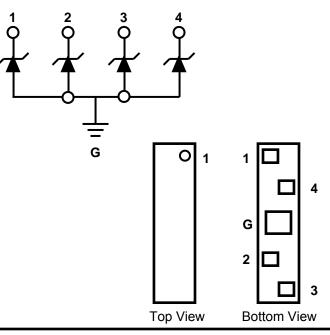
* Halogen Free refers to: Br≤900ppm, Cl≤900ppm, Br+Cl≤1500ppm SESD devices meet MSL-1 Requirements DFN case epoxy meets UL 94 V-0



PART NUMBERING



SCHEMATIC AND PIN CONFIGURATION





DEVICE MAXIMUM RATING

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DOCUMENT: SCD28189 REV LETTER: A REV DATE: December 6, 2011 PAGE NO.: Page 2 of 6

ESD Wit (IEC 61000-	hstand ⁽¹⁾ 4-2, level 4)	Temperature		Peak Current (tp=8x20μs)
Contact (kV)	Air (kV)	Operating (°C)	Storage (°C)	lpp (A)
± 20	± 20	-55 to +125	-55 to +150	2.0

⁽¹⁾ 20kV @ ± 1 pulse; 10kV @ ± 50 pulses; 8kV @ 1,000 pulses (under IEC6100-4-2)

• Device maximum rating @ T = 25°C, unless otherwise specified

• Caution: Stress exceeding Device Maximum Ratings may damage the device

Prolonged exposure to stresses above the Recommended Operating Conditions may affect device reliability

DEVICE ELECTRICAL CHARACTERISTICS

	Input CapacitanceBreakdown VoltageReverse WorkingReverse Leakage Curr0V, f = 3GHz, I/O to GND (pF)VBR @ IT=1mA (V)Voltage (V)IL @ VWRV=5.0V (nA)		0	Clamping Voltage V _{CL} @ lpp=2.0A (V)			
Тур	Maximum	Тур	Min	Max	Тур	Max	Max
0.20	0.22	+9.00 / -0.80	0	+8.00	<5.0	50.0	+9.18 / -0.80

All device electrical characteristics @ T = 25°C, unless otherwise specified

FIGURE 1. INSERTION LOSS DIAGRAM

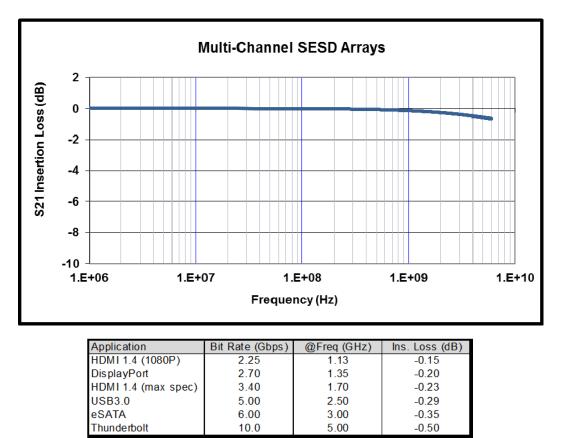




FIGURE 2. DEVICE IV CURVE



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DOCUMENT: SCD28189 REV LETTER: A REV DATE: December 6, 2011 PAGE NO.: Page 3 of 6

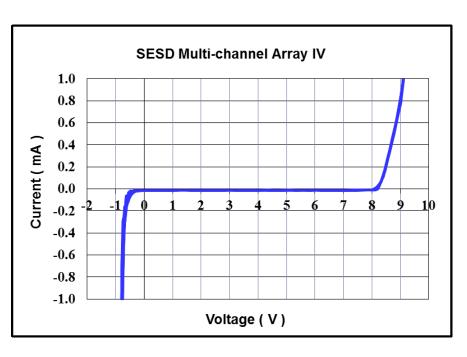
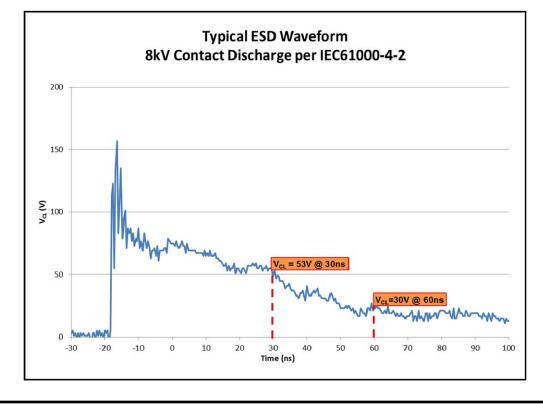
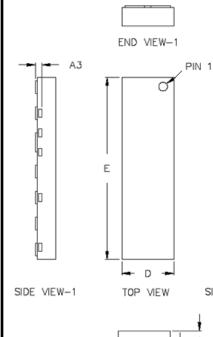


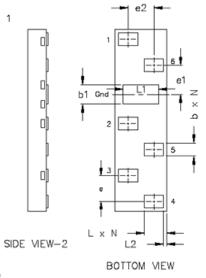
FIGURE 3. ESD WITHSTAND





DEVICE DIMENSIONS





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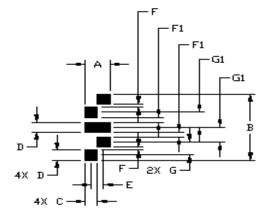
	SESD0802Q4UG-0020-090						
	N	lillimeter	s	Inches			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.30	0.31	0.32	0.0118	0.0122	0.0126	
A1	0.00		0.05	0.0000		0.0020	
A3		0.10 ref		(0.004 ret	f.	
D	0.50	0.60	0.70	0.020	0.024	0.028	
E	1.902.000.150.20		2.10	0.075	0.079	0.083	
b			0.25	0.006	800.0	0.010	
b1	0.25 0.30	0.36	0.010	0.012	0.014		
L	0.25 0.30 0.35 0.4		0.35	0.010	0.012	0.014	
L1			0.45	0.014	0.016	0.018	
L2	0.05 BSC			0	.002 BS	С	
е	0.40 BSC			0	.016 BS	С	
e1	0.45 BSC			0.018 BSC			
e2	0.25 BSC			0.010 BSC			
Ν		4			4		

BSC – Basic Spacing between Centers

END VIEW-2

RECOMMENDED LANDING PATTERN:

A1



PAD LAYOUT

SESD Landing Pad Layout 5 Pin 4-ch Miniature FT Array						
Symbol	Symbol Millimeters Inches					
Α	0.60	0.024				
В	2.00	0.079				
С	0.30	0.012				
D	0.30	0.012				
E	0.30	0.012				
F	0.10	0.004				
F1	0.15	0.006				
G	0.40 BSC	0.016 BSC				
G1	0.45 BSC	0.018 BSC				

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PACKAGING

Packaging	Tape & Reel	Standard Box
SESD0802Q4UG-0020-090	5,000	25,000

PRODUCT: SESD0802Q4UG-0020-090

DOCUMENT: SCD28189 REV LETTER: A REV DATE: December 6, 2011 PAGE NO.: Page 4 of 6

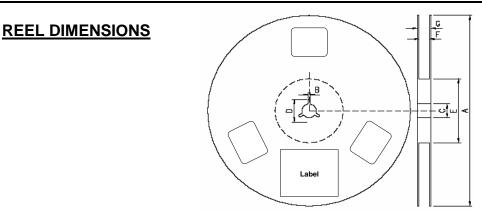


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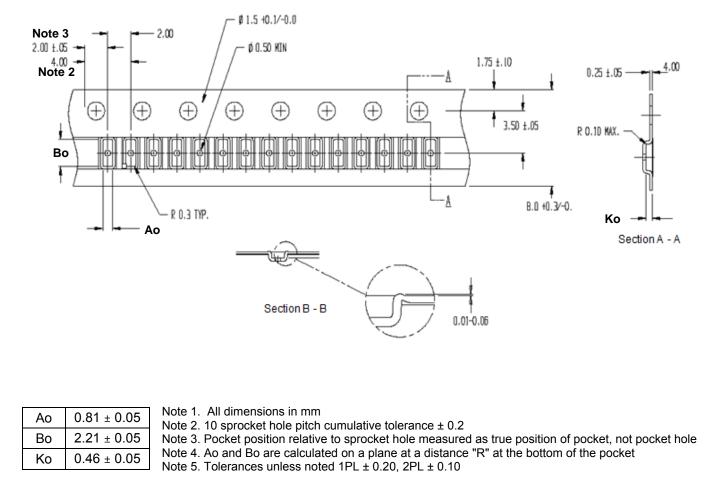
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DOCUMENT: SCD28189 REV LETTER: A REV DATE: December 6, 2011 PAGE NO.: Page 5 of 6



Dimensions	Α	В	С	D	Е	F	G
(mm)	180.0 ± 1.5	2.3. 0 ± 0.2	13.0 + 0.5 / -0.2	17.3 ± 0.2	60.5 ± 1.5	8.4 +1.5/-0.0	14.4 (max)

CARRIER TAPE DIMENSIONS





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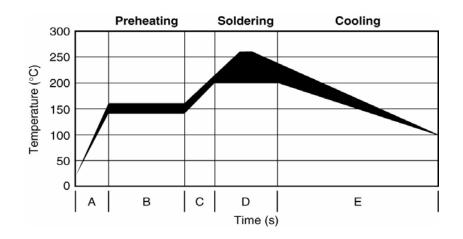
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DOCUMENT: SCD28189 REV LETTER: A REV DATE: December 6, 2011 PAGE NO.: Page 6 of 6

SOLDER REFLOW RECOMMENDATION

А	Temperature ramp up 1	From ambient to Preheating temperature	30s to 60s
В	Preheating	140°C - 160°C	60s to 120s
С	Temperature ramp up 2	From Preheating to Main heating temperature	20s to 40s
D	Main heating	at 200°C at 220°C at 240°C at 260°C	60s ~ 70s 50s ~ 60s 30s ~ 40s 5s ~ 10s
Е	Cooling	From main heating temperature to 100°C	4°C/s (max)

FIGURE 4. REFLOW PROFILE



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